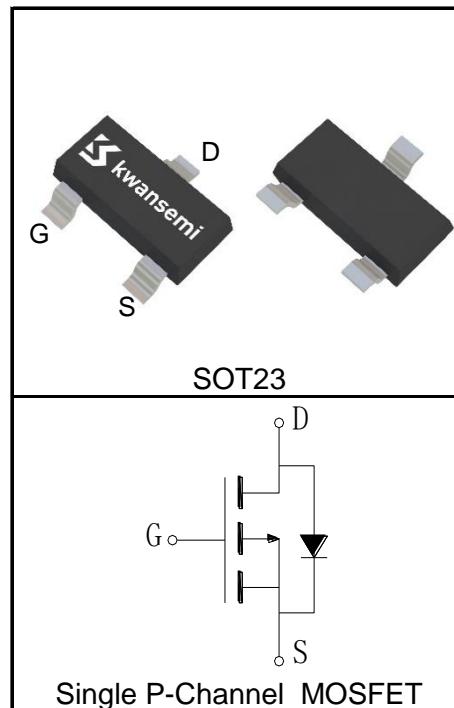


## Features

- -60V/-2A
- $R_{DS(ON)} = 115\text{m}\Omega$ (Typ.)@ $V_{GS}=-10\text{V}$
- $R_{DS(ON)} = 135\text{m}\Omega$ (Typ.)@ $V_{GS}=-4.5\text{V}$
- Low  $R_{DS(ON)}$
- Super High Dense Cell Design
- Reliable and Rugged

## Pin Description



## Applications

- Load Switch



Halogen-Free

## Absolute Maximum Ratings

Symbol	Parameter	Rating	Unit
<b>Common Ratings</b> ( $T_A=25^\circ\text{C}$ Unless Otherwise Noted)			
$V_{DSS}$	Drain-Source Voltage	-60	V
$V_{GSS}$	Gate-Source Voltage	$\pm 20$	
$T_{Jmax}$	Maximum Junction Temperature	150	$^\circ\text{C}$
$T_J, T_{STG}$	Operating and Storage Temperature Range	-55 to 150	$^\circ\text{C}$
$I_S$	Diode Continuous Forward Current	$T_A=25^\circ\text{C}$	-1.2
			A

### Mounted on Large Heat Sink

$I_{DP}^{(1)}$	Pulse Drain Current	$T_A=25^\circ\text{C}$	-8	A
$I_D^{(2)}$	Continuous Drain Current( $V_{GS}=-10\text{V}$ )	$T_A=25^\circ\text{C}$	-2	A
		$T_A=70^\circ\text{C}$	-1.6	
$P_D$	Maximum Power Dissipation	$T_A=25^\circ\text{C}$	1	W
		$T_A=70^\circ\text{C}$	0.64	
$R_{\theta JL}$	Thermal Resistance-Junction to Lead	80	$^\circ\text{C}/\text{W}$	
$R_{\theta JA}^{(3)}$	Thermal Resistance-Junction to Ambient	125	$^\circ\text{C}/\text{W}$	

### Drain-Source Avalanche Ratings

$E_{AS}^{(4)}$	Avalanche Energy, Single Pulsed	25	mJ
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**Electrical Characteristics** ( $T_A=25^\circ\text{C}$  Unless Otherwise Noted)

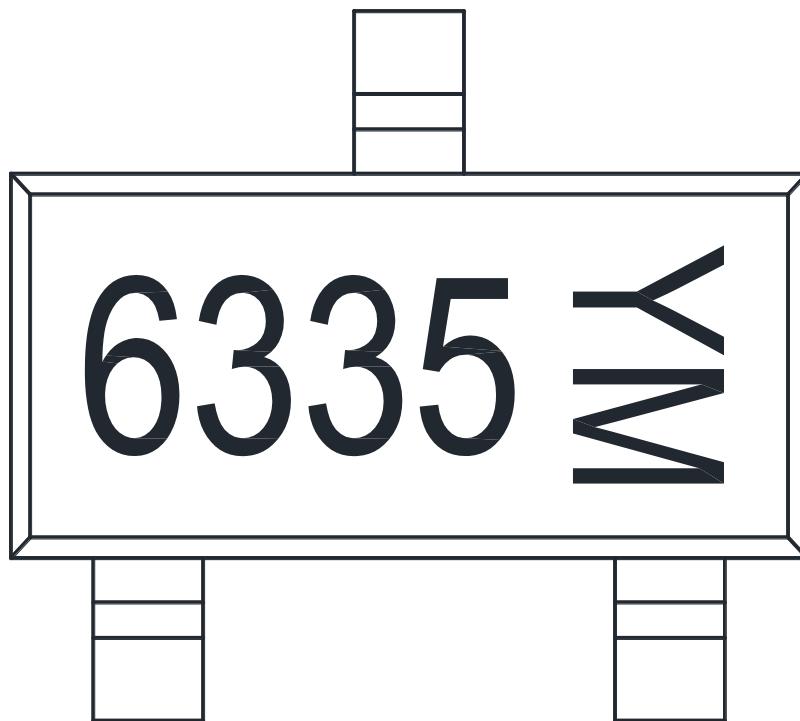
Symbol	Parameter	Test Condition	Rating			Unit
			Min.	Typ.	Max.	
<b>Static Characteristics</b>						
$\text{BV}_{\text{DSS}}$	Drain-Source Breakdown Voltage	$\text{V}_{\text{GS}}=0\text{V}, \text{I}_{\text{DS}}=-250\mu\text{A}$	-60			V
$\text{I}_{\text{DSS}}$	Zero Gate Voltage Drain Current	$\text{V}_{\text{DS}}=-60\text{V}, \text{V}_{\text{GS}}=0\text{V}$			-1	$\mu\text{A}$
		$\text{T}_J=125^\circ\text{C}$			-30	
$\text{V}_{\text{GS}(\text{th})}$	Gate Threshold Voltage	$\text{V}_{\text{DS}}=\text{V}_{\text{GS}}, \text{I}_{\text{DS}}=-250\mu\text{A}$	-1.2	-1.7	-2.3	V
$\text{I}_{\text{GSS}}$	Gate Leakage Current	$\text{V}_{\text{GS}}=\pm 20\text{V}, \text{V}_{\text{DS}}=0\text{V}$			$\pm 100$	nA
$\text{R}_{\text{DS}(\text{ON})}^{(5)}$	Drain-Source On-state Resistance	$\text{V}_{\text{GS}}=-10\text{V}, \text{I}_{\text{DS}}=-2\text{A}$		115	140	$\text{m}\Omega$
		$\text{V}_{\text{GS}}=-4.5\text{V}, \text{I}_{\text{DS}}=-1\text{A}$		135	170	$\text{m}\Omega$
<b>Diode Characteristics</b>						
$\text{V}_{\text{SD}}^{(5)}$	Diode Forward Voltage	$\text{I}_{\text{SD}}=-2\text{A}, \text{V}_{\text{GS}}=0\text{V}$		-0.82	-1.2	V
$\text{t}_{\text{rr}}$	Reverse Recovery Time	$\text{I}_{\text{SD}}=-2\text{A}, \frac{d\text{I}_{\text{SD}}}{dt}=-100\text{A}/\mu\text{s}$		29		ns
$\text{Q}_{\text{rr}}$	Reverse Recovery Charge			44		nC
<b>Dynamic Characteristics</b> <sup>(6)</sup>						
$\text{R}_G$	Gate Resistance	$\text{V}_{\text{GS}}=0\text{V}, \text{V}_{\text{DS}}=0\text{V}, \text{F}=1\text{MHz}$		12		$\Omega$
$\text{C}_{\text{iss}}$	Input Capacitance	$\text{V}_{\text{GS}}=0\text{V}, \text{V}_{\text{DS}}=-30\text{V}, \text{Frequency}=1.0\text{MHz}$		920		$\text{pF}$
$\text{C}_{\text{oss}}$	Output Capacitance			35		
$\text{C}_{\text{rss}}$	Reverse Transfer Capacitance			30		
$\text{t}_{\text{d}(\text{ON})}$	Turn-on Delay Time	$\text{V}_{\text{DD}}=-30\text{V}, \text{I}_{\text{DS}}=-2\text{A}, \text{V}_{\text{GEN}}=-10\text{V}, \text{R}_G=6\Omega$		15		ns
$\text{t}_{\text{r}}$	Turn-on Rise Time			17		
$\text{t}_{\text{d}(\text{OFF})}$	Turn-off Delay Time			32		
$\text{t}_{\text{f}}$	Turn-off Fall Time			19		
<b>Gate Charge Characteristics</b> <sup>(6)</sup>						
$\text{Q}_g$	Total Gate Charge	$\text{V}_{\text{DS}}=-30\text{V}, \text{V}_{\text{GS}}=-10\text{V}, \text{I}_{\text{DS}}=-2\text{A}$		15		nC
$\text{Q}_{\text{gs}}$	Gate-Source Charge			3.1		
$\text{Q}_{\text{gd}}$	Gate-Drain Charge			4.2		

Notes:

- ①Pulse width limited by safe operating area.
- ②Calculated continuous current based on maximum allowable junction temperature.
- ③When mounted on 1 inch square copper board,  $t \leq 10\text{sec}$ . The value in any given application depends on the user's specific board design.
- ④Limited by  $T_{J\max}$ , Starting  $T_J = 25^\circ\text{C}$ ,  $I_{AS\max} = -10\text{A}$ ,  $L = 0.5\text{mH}$ ,  $V_{DD} = -48\text{V}$ ,  $R_G = 25\Omega$ ,  $V_{GS} = -10\text{V}$ . Part not recommended for use above this value.
- ⑤Pulse test; Pulse width  $\leq 300\mu\text{s}$ , duty cycle  $\leq 2\%$ .
- ⑥Guaranteed by design, not subject to production testing.

**Ordering and Marking Information**

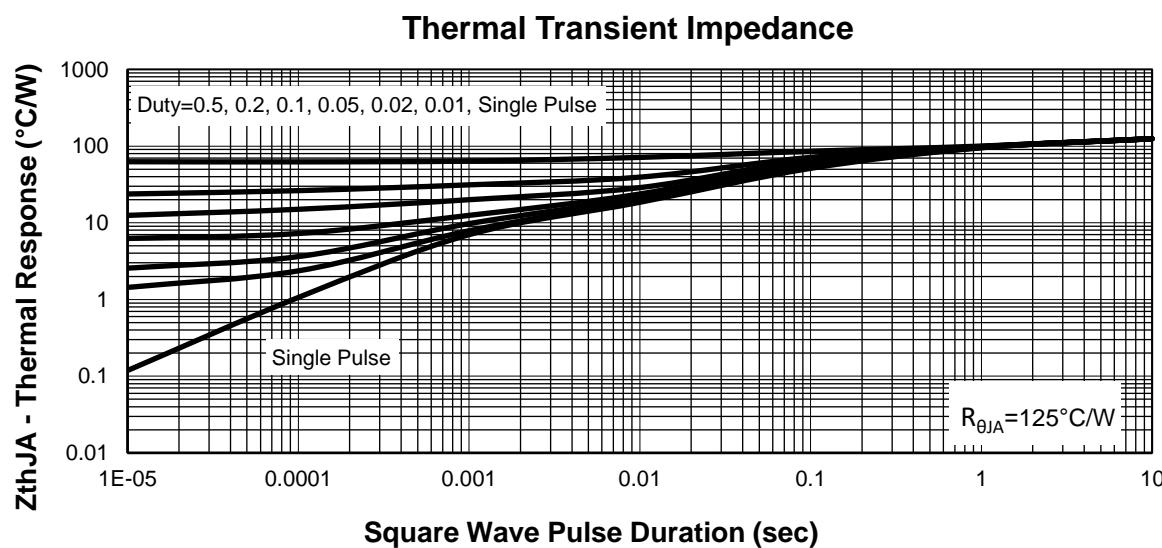
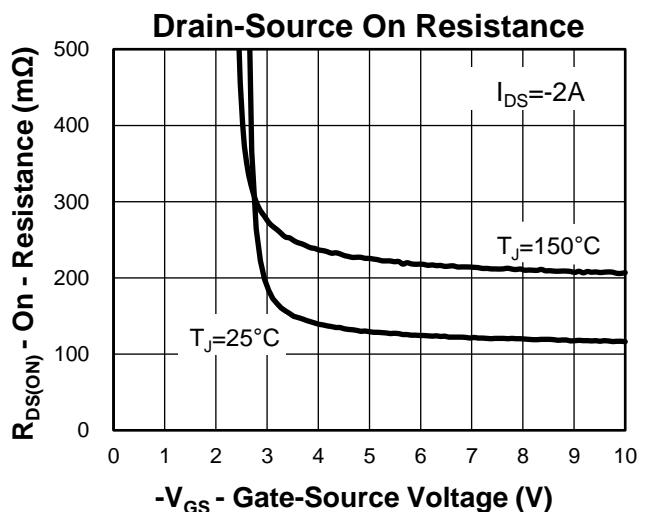
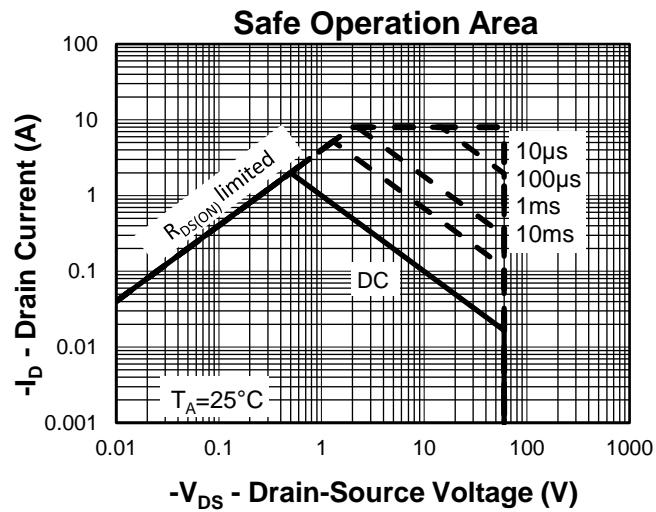
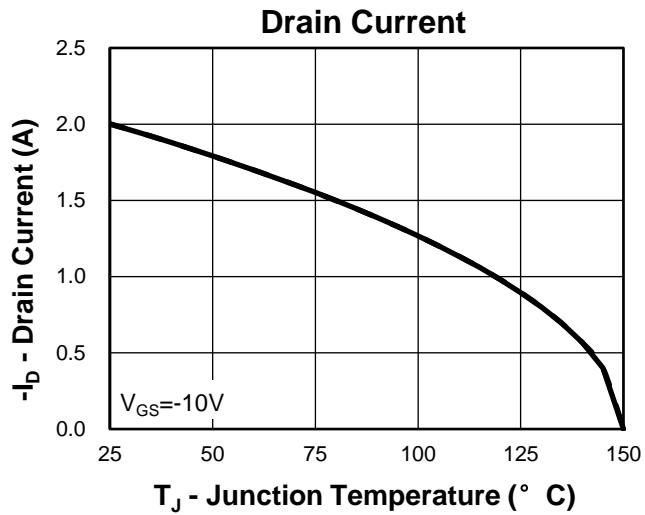
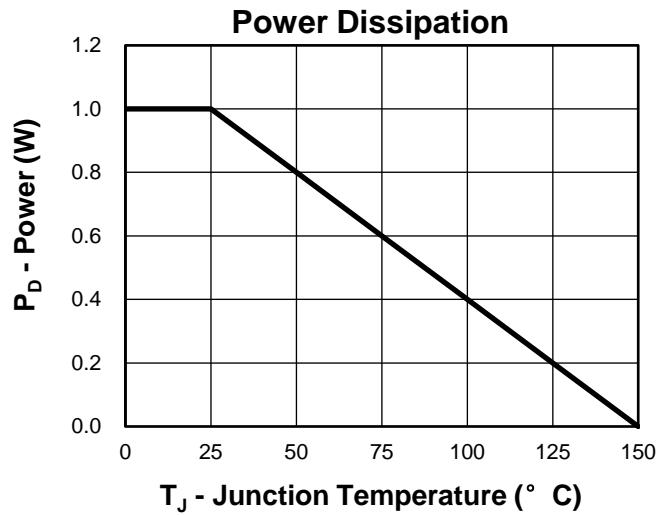
Device	Package	Packaging	Quantity	Reel Size	Tape width
KS6335AA	SOT23	Tape&Reel	3000	7"	8mm



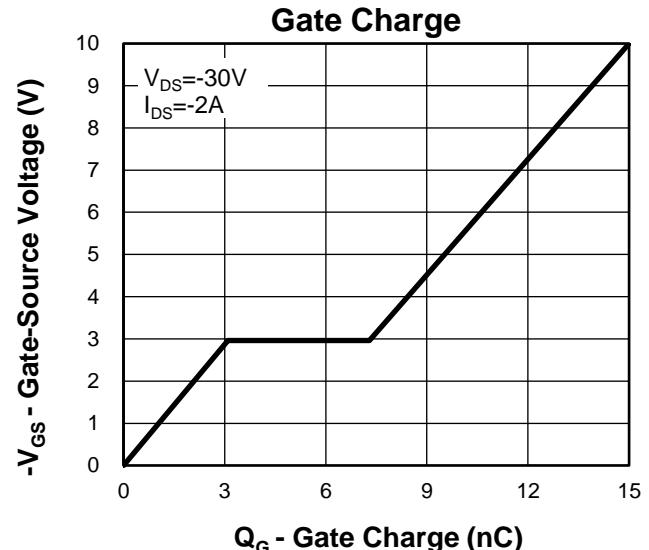
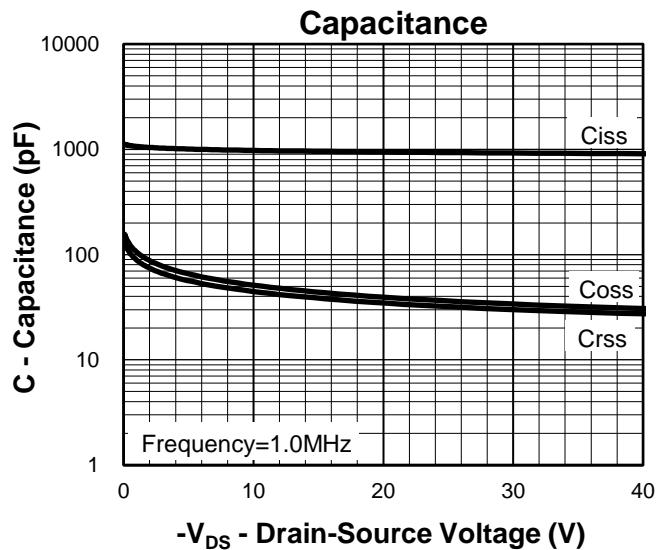
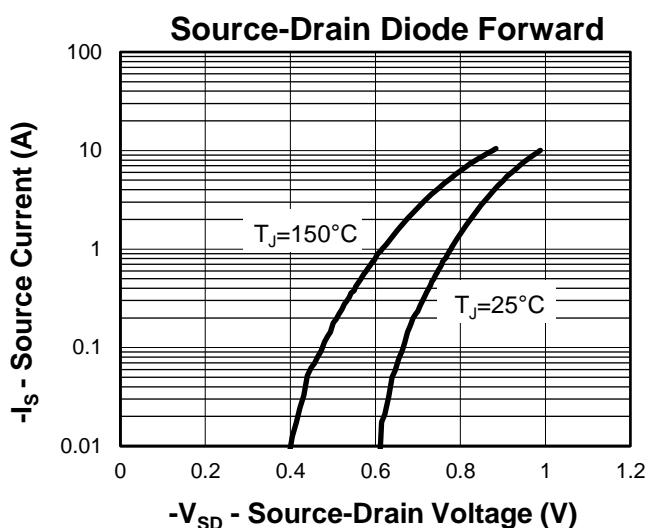
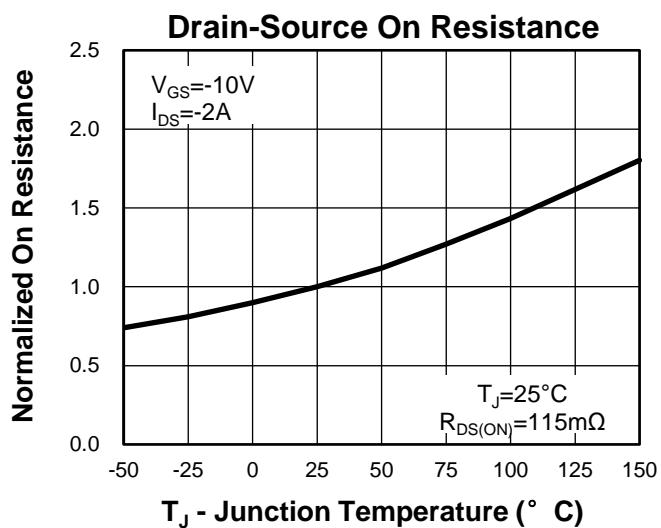
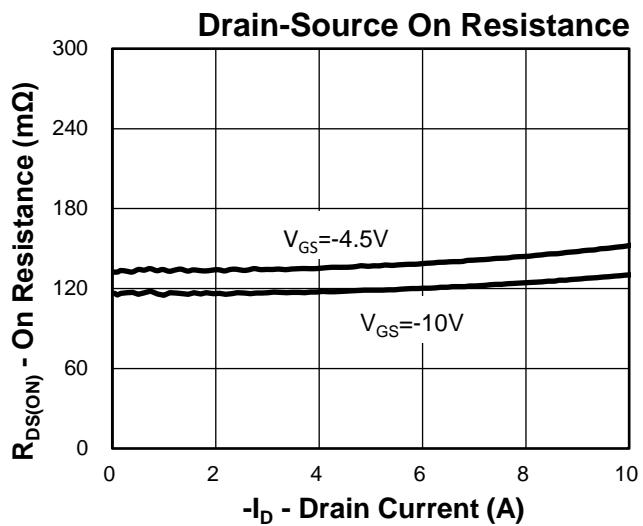
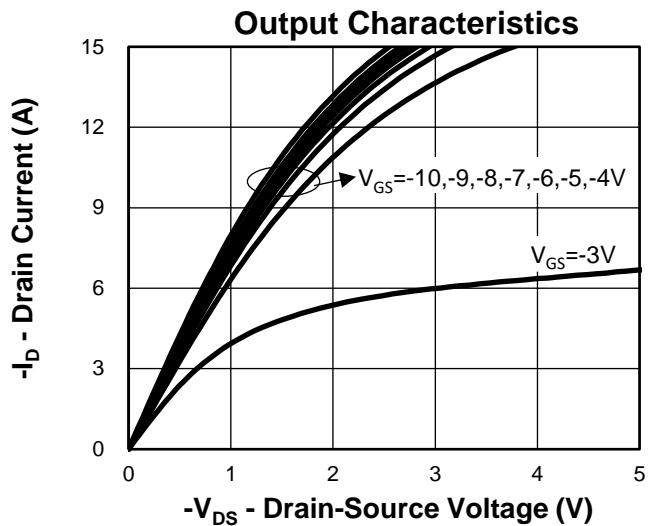
Y =Year,2017-A,2018-B,etc.

M =Month,Jan-1,Feb-2,...,Sep-9,Oct-A,Nov-B,Dec-C.

## Typical Characteristics

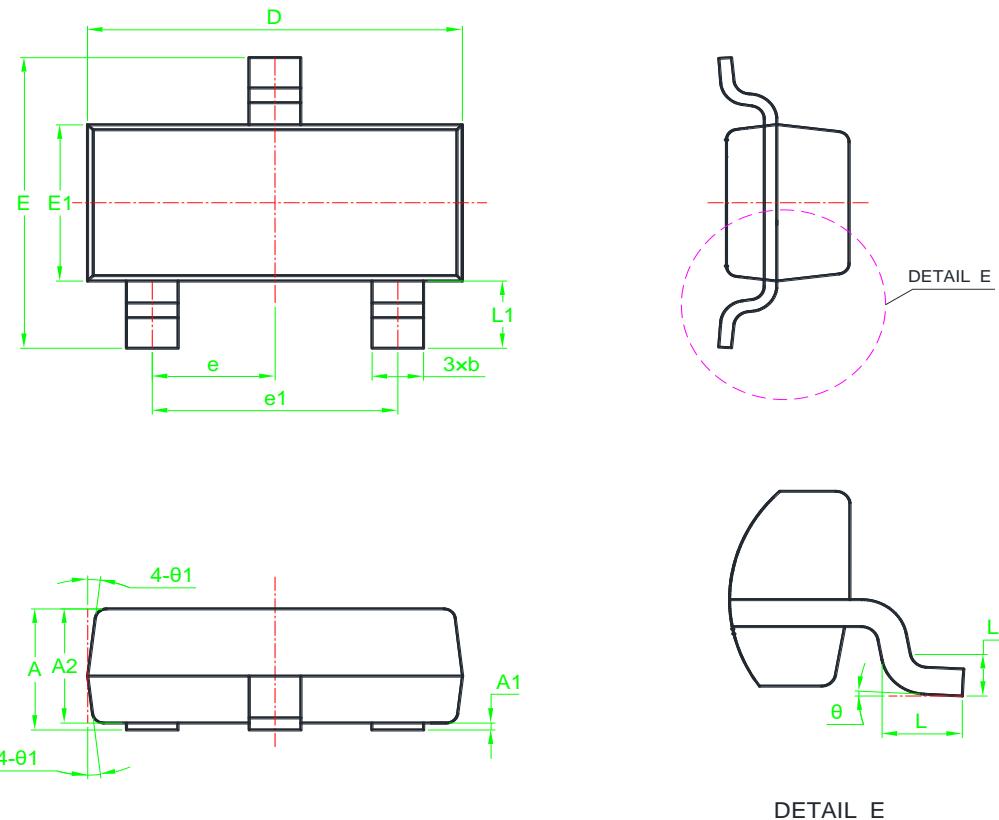


## Typical Characteristics



## Package Information

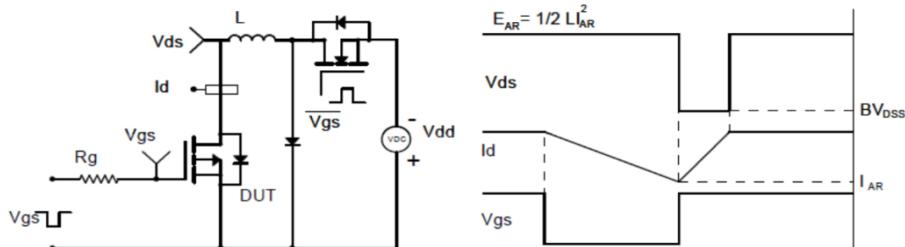
### SOT23



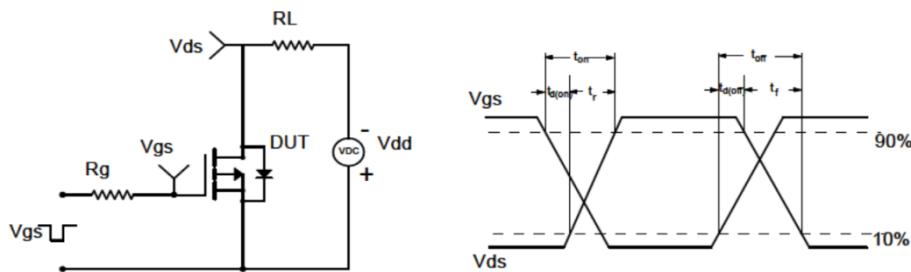
SYMBOL	MM			INCH			SYMBOL	MM			INCH		
	MIN	NOM	MAX	MIN	NOM	MAX		MIN	NOM	MAX	MIN	NOM	MAX
A	0.90	*	1.12	0.035	*	0.044	e	0.95BSC			0.037BSC		
A1	0.01	*	0.10	0.000	*	0.004	e1	1.90BSC			0.075BSC		
A2	0.80	0.90	1.02	0.031	0.035	0.040	L	0.30	0.40	0.50	0.012	0.016	0.020
b	0.30	0.40	0.50	0.012	0.016	0.020	L1	0.54REF			0.021REF		
D	2.80	2.90	3.00	0.110	0.114	0.118	L2	0.254BSC			0.010BSC		
E	2.25	2.40	2.55	0.089	0.094	0.100	θ	0°	*	8°	0°	*	8°
E1	1.20	1.30	1.40	0.047	0.051	0.055	θ1	0°	*	10°	0°	*	10°

Note: Dimensions do not include burrs and mold flash.

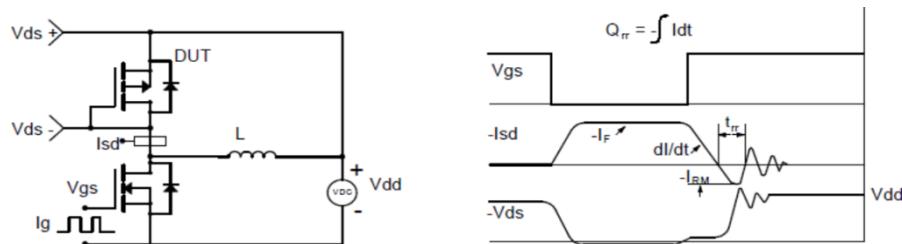
### Avalanche Test Circuit and Waveforms



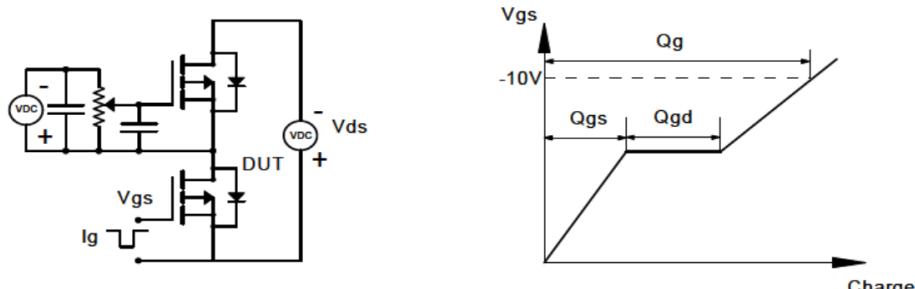
### Switching Time Test Circuit and Waveforms



### Diode Recovery Test Circuit and Waveforms



### Gate Charge Test Circuit and Waveform



### Customer Service

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Web:[www.kwansemi.com](http://www.kwansemi.com)

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